Patent Claims

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- 1. A method for carrying out a scattered light measurement, the optical beam guidance being set up such that the intensities of the scattered and transmitted components of the light are measured separately.
- The method as claimed in claim 1, wherein the scattered and transmitted components of the incident light are separated by a specially shaped diaphragm.
- 3. The method as claimed in claims 1 and 2 constructed to the effect that the diaphragm has a region for accommodating a detector or for accommodating a beam guidance or deflection arrangement.
- 20 4. The method as claimed in claim 1, wherein the scattered and transmitted components of the incident light are separated by a specially constructed mirror inserted into the beam path with the accommodation of a beam guidance or deflection unit.
- 5. The method as claimed in claim 1, wherein the scattered and transmitted components of the incident light are separated by a specially machined lens inserted into the beam path with simultaneous accommodation of a diaphragm and beam guidance or deflection unit.
- 6. The method as claimed in claim 1, wherein the detector for measuring the intensity of the transmitted component is equipped with additional wavelength-selective components.

7. The method as claimed in claims 1 to 6, wherein the signals of the scattered and transmitted components are measured both temporally separately and simultaneously.

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8. The method as claimed in claims 1 to 5, wherein the intensity of the light source is readjusted by the light directly transmitted from the source.

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- 9. The method as claimed in claims 1 to 5, wherein setting, testing and, if appropriate, correction of the position of a vessel for accommodating material to be measured, which vessel is moved 15 through the measuring beam, are effected in such a way that, by means of step-by-step scanning of a vessel during its movement through the measuring beam, the transmitted signal is recorded as a function of the position of said vessel and is used to define the position of the accommodating vessel relative to the measuring beam.
- . 10. The method as claimed in claims 1 to 9, wherein the method can be used as in-process control for 25 the purpose of validation in automatic diagnostic analyzers.
 - The method as claimed in claims 1 to 9 for use in 11. analysis.

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The method as claimed in claims 1 to 9 for use in 12. in-vitro diagnosis.